

APT15DQ120KG Ultrafast Soft Recovery Rectifier Diode

Product Overview

The APT15DQ120KG is a 1200 V, 15 A Ultrafast Soft Recovery Rectifier Si Diode in a TO-220 package.



Features

The following are key features of the APT15DQ120KG device:

- Ultrafast recovery times
- Soft recovery characteristics
- Low forward voltage
- Low leakage current
- Avalanche-energy rated
- RoHS compliant
- AEC-Q101 qualified

Benefits

The following are benefits of the APT15DQ120KG device:

- High switching frequency
- Low switching losses
- Low noise (EMI) switching
- Higher reliability systems
- Increased system power density

Applications

The APT15DQ120KG device is designed for the following applications:

- Power factor correction (PFC)
- Anti-parallel diode
 - Switch-mode power supply
 - Inverters/converters
 - Motor controllers
- Freewheeling diode
 - Switch-mode power supply
 - Inverters/converters
- Snubber/clamp diode



Device Specifications

This section shows the specifications of the APT15DQ120KG device.

Absolute Maximum Ratings

The following table shows the absolute maximum ratings of the APT15DQ120KG device.

T_c = 25 °C, unless otherwise specified.

Table 1 • Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
V _R	Maximum DC reverse voltage	1200	V
V _{RRM}	Maximum peak repetitive reverse voltage		
V _{RWM}	Maximum working peak reverse voltage		
I _{F(AV)}	Maximum average forward current (T_c = 127 °C, duty cycle = 0.5)	15	А
I _{FSM}	Non-repetitive forward surge current (T_J = 45 °C, 8.3 ms)	110	
E _{AVL}	Avalanche-energy (1 A, 40 mH)	20	mJ

The following table shows the thermal and mechanical characteristics of the APT15DQ120KG device.

Table 2 • Thermal and Mechanical Characteristics

Symbol	Characteristic	Min	Тур	Max	Unit
R _{θJC}	Junction-to-case thermal resistance			1.18	°C/W
T _J , T _{STG}	Operating and storage temperature range	-55		175	°C
TL	Lead temperature for 10 seconds			300	
Wt	Package weight		0.07		OZ
			1.9		g
	Mounting torque, 6-32 or M3 screw			10	lbf∙m
				1.1	N∙m



Electrical Performance

The following table shows the static characteristics of the APT15DQ120KG device. $T_J = 25$ °C, unless otherwise specified.

Table 3 • Static Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
V _F	Forward voltage	I _F = 15 A		2.8	3.3	V
		I _F = 30 A		3.4		
		I _F = 15 A, T _J = 125 °C		2.5		
I _{RM}	Maximum reverse leakage current	V _R = 1200 V			100	μΑ
		V _R = 1200 V, T _J = 125 °C			500	
Cj	Junction capacitance	V _R = 200 V		17		pF

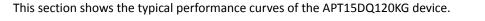
The following table shows the dynamic characteristics of the APT15DQ120KG device.

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
t _{rr}	Reverse recovery time	$I_F = 1 \text{ A; } di_F/dt = -100 \text{ A/}\mu\text{s}$ $V_R = 30 \text{ V}$		21		ns
t _{rr}	Reverse recovery time	I _F = 15 A; di _F /dt = -200 A/μs V _R = 800 V		240		ns
Q _{rr}	Reverse recovery charge	к		260		nC
I _{RRM}	Maximum reverse recovery current			3		A
t _{rr}	Reverse recovery time	I _F = 15 A; di _F /dt = -200 A/μs V _R = 800 V; T _J = 125 °C		290		ns
Q _{rr}	Reverse recovery charge	· · · · · · · · · · · · · · · · · · ·		960		nC
I _{RRM}	Maximum reverse recovery current			6		A
t _{rr}	Reverse recovery time	I _F = 15 A; di _F /dt = -1000 A/μs V _R = 800 V; T ₁ = 125 °C		130		ns
Q _{rr}	Reverse recovery charge	· · · · · · · · · · · · · · · · · · ·		1340		nC
I _{RRM}	Maximum reverse recovery current			19		A

Table 4 • Dynamic Characteristics



Typical Performance Curves



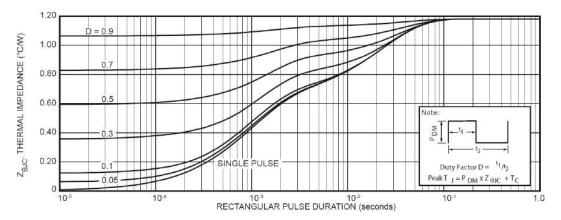


Figure 1 • Maximum Transient Thermal Impedance

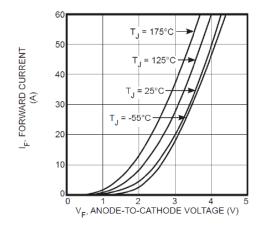


Figure 2 • Forward Current vs. Forward Voltage

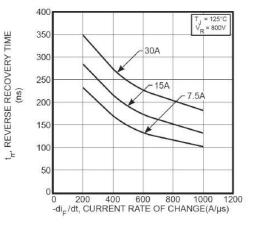
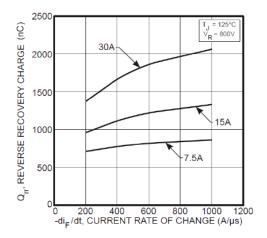


Figure 3 • Reverse Recovery Time vs. Current Rate of Change



30A



IRM[,] REVERSE RECOVERY CURRENT (A) 20 15 15A 10 7.5A 0 200 400 600 800 1000 1200 -di_F/dt, CURRENT RATE OF CHANGE (A/µs)

25

= 125°C = 800V

Figure 4 • Reverse Recovery Charge vs. Current **Rate of Change**

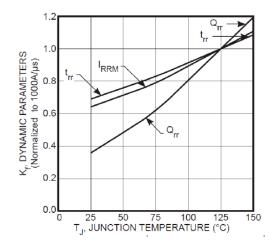


Figure 6 • Dynamic Parameters vs. Junction Temperature

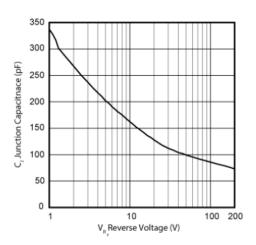


Figure 8 • Junction Capacitance vs. Reverse Voltage

Figure 5 • Reverse Recovery Current vs. Current **Rate of Change**

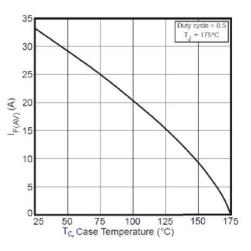


Figure 7 • Maximum Average Forward Current vs. **Case Temperature**



Reverse Recovery Overview

The following figure illustrates the diode test circuit of the APT15DQ120KG device.

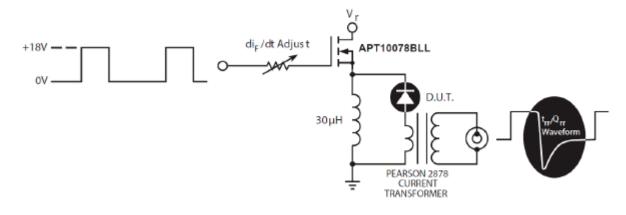


Figure 9 • Diode Test Circuit

The following figure illustrates the diode reverse recovery waveform and definitions of the APT15DQ120KG device.

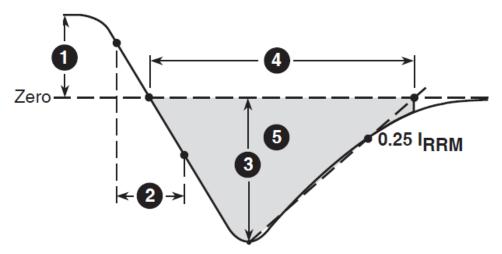


Figure 10 • Diode Reverse Recovery Waveform and Definitions

- **1.** I_F —Forward conduction current.
- **2.** di_F/dt —Rate of diode current change through zero crossing.
- **3.** I_{RRM}—Maximum reverse recovery current.
- **4.** t_{rr} —Reverse recovery time, measured from zero crossing where diode current goes from positive to negative, to the point at which the straight line through I_{RRM} and 0.25 I_{RRM} passes through zero.
- 5. Q_{rr} —Area under the curve defined by I_{RRM} and t_{rr} .



Package Specification

This section shows the package specification of the APT15DQ120KG device.

Package Outline Drawing

The following figure illustrates the TO-220 package outline of the APT15DQ120KG device.

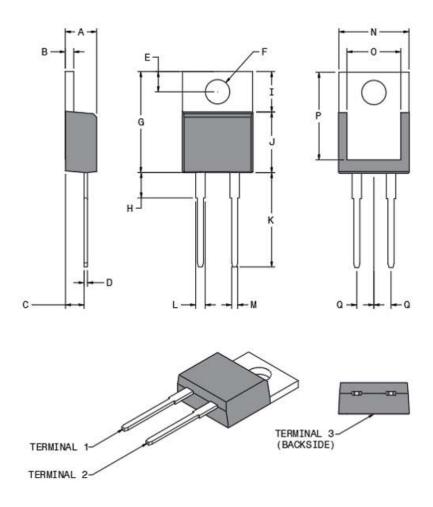


Figure 11 • Package Outline Drawing



The following table shows the TO-220 dimensions and should be used in conjunction with the package outline drawing.

Table 5 • TO-220 Dimensions

SYMBOL	MIN	МАХ	MIN	МАХ	
	[mm]	[mm]	[INCH]	[INCH]	
А	4.32	4.57	0.170	0.180	
В	1.14	1.40	0.045	0.055	
С	2.50	2.74	0.098	0.108	
D	0.36	0.53	0.014	0.021	
E	2.65	3.05	0.104	0.120	
F	3.60	3.96	0.142	0.156	
G	14.50	15.60	0.571	0.614	
Н	2.39	3.65	0.094	0.144	
1	6.00	6.80	0.236	0.268	
L	8.40	9.00	0.331	0.354	
К	13.00	14.00	0.512	0.551	
L	1.23	1.39	0.048	0.055	
М	0.69	0.88	0.027	0.035	
Ν	10.00	10.36	0.394	0.408	
0	7.57	7.90	0.298	0.311	
Р	12.20	13.10	0.480	0.516	
Q	2.54 BSC		0.100 BSC		
TERMINAL 1	CATHODE				
TERMINAL 2	ANODE				
TERMINAL 3	CATHODE				





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053-4222 | April 2020 | Released